

Notice of References Cited

Application/Control No.

10/642,286

Applicant(s)/Patent Under

Reexamination

INUKAI ET AL.

Examiner

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Art Unit

3682

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,813,920	03-1989	Inukai et al.	474/240
	B	US-6,283,882	09-2001	Nonaka et al.	474/242
	C	US-6,293,886	09-2001	Ohkawa et al.	474/242
	D	US-6,500,086	12-2002	Serkh et al.	474/245
	E	US-6,464,606	10-2002	Brandsma et al.	474/242
	F	US-6,679,798	01-2004	Takagi et al.	474/242
	G	US-6,857,980	02-2005	van Liempd et al.	474/242
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-82637 A	03-1999	Japan	Sato et al.	F16G 5/16
	O	JP 2000-120799 A	04-2000	Japan	Takahshi	F16G 5/16
	P	JP (2000-104796 A	04-2000	Japan	Sato et al.	F16G 5/16
	Q	JP 2001-3994 A	01-2001	Japan	Sakanaka et al.	F16G 5/16
	R	JP 2000-310294 A	11-2000	Japan	Ebi	F16G 5/16
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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